## Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|---|
| 10717942                | BAI ET AL.                              |
| Examiner                | Art Unit                                |
| Keefer, Michael E       | 2154                                    |

| SEARCHED |     |          |          |          |
|----------|-----|----------|----------|----------|
| Class    |     | Subclass | Date     | Examiner |
| 709      | 235 |          | 7/3/2007 | MEK      |

| SEARCH NOTES                     |          |          |  |  |  |
|----------------------------------|----------|----------|--|--|--|
| Search Notes                     | Date     | Examiner |  |  |  |
| EAST Search                      | 7/6/2007 | MEK      |  |  |  |
| Consulted Examiner Joshua Joo    | 7/3/2007 | MEK      |  |  |  |
| Consulted Examiner Adam Weintrop | 7/5/2007 | MEK      |  |  |  |

| INTERFERENCE SEARCH |          |      |          |  |
|---------------------|----------|------|----------|--|
| Class               | Subclass | Date | Examiner |  |

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